

## Size and quantum effects in InN nanodomains

## Justification of work

- InN intrinsic semiconductor
- Band gap 0.6-0.8 eV
- Electric surface effects
- $\rightarrow$  high density of surface states  $\rightarrow$  high density of surface electrons $\rightarrow$  electron confinement in nanodomains



- Semiconductors
- **†**Solar shells
- Charge memory devices
- Size and quantum effects in 2-D InN nanotextures

#### Overview

- Physical principles
- Methodology of growing 2-D InN nanotextures (10nm).

#### Demonstrate

- Schottky diode (metal-semiconductor-metal): operation with C-AFM.
- Charge memory effects (I-V, hysterisis loop).
- → Electron confinement on boundary of nanodomains → Scattering of wavefunctions on 2-D InN boundaries.

#### InN semiconductor



#### Surface charge effects

#### 2-D nanotextures



 $\rightarrow$  Breaking of translational symmetry  $\rightarrow$  charge accumulation on the boundaries  $\rightarrow$  charge confinement  $\rightarrow$  charge memory effects

#### Translational symmetry in space

**Space homogenuity** 

$$T \psi(\vec{r}) = \psi(\vec{r} + \vec{a})$$
$$\psi_k(\vec{r}) = \psi_{0k}(\vec{r}) \exp i(\vec{\kappa} \bullet \vec{r})$$

$$\vec{P} = \hbar \vec{\kappa}$$

$$E(k) = \frac{\hbar k^2}{2m}$$



#### Translational symmetry in crystals



#### Breaking of translational symmetry

**Complex wavenumber** 

$$k = ik_1 + k_2$$



#### Boundary energy states



#### Charge confinement on boundaries of nanodomains



#### Growth of InN 2-D nanotextures by pulsed laser deposition at 157 nm



F<sub>2</sub> Laser:157 *nm*, E =20 *mJ/pulse*, 15 Hz rep.rate Target : InN Substrate : Si / Ta **Distance between target** and substrate 0.3 cm Background gas: N<sub>2</sub> 105 Pa Growth rate of the film : 170 nm / h







#### InN film morphology





- (a) TEM image of destroyed nanocrystalline domains deposited on Ni grids following electron irradiation.
- (b) (b) EDXS of the e-beam irradiated crystal nanodomains. Only an indium peak is recorded.
- (c) (c) Indium nanocrystalline sphere of tetragonal structure formed after ebeam irradiation.
- (d) (d) SAED of the nanosphere with the tetragonal crystalline structure of pure indium



Morphology of InN nanostructures on Ta substrate by 157 nm PLD. (a) 5 nm crystal domains (A), 40 nm crystal domains (C), amorphus oxinitrile  $In-O_y-N_x$  phase (E), boundary between amoprhus and crystal phase (F). (b) Crystal cubic  $In_2O_3$  [112] nanodomains. 25 nm crystal domains (B), Crystal 2-D nanostructures rotated with

respect to each other (D).

#### AFM and C-AFM images of InN film



#### I-V response of InN nanodomains-Schottky diode charge memory effects







#### C-AFM of InN nanodomains







## C-AFM scanning





# Field effect in intrinsic InN semiconductors

$$\pm \left| \nabla (V(r) \right| = 2\left(\frac{2e^2 nkT}{\varepsilon \varepsilon_0}\right)^{1/2} \sinh\left(\frac{V(r)}{2kT}\right)$$
$$n(r) = \frac{\varepsilon \varepsilon_0}{e} \frac{d^2 V(r)}{dr^2} \Longrightarrow n_s(r) = -en_v(\exp\left(-\frac{V_s}{kT}\right) - \exp\left(\frac{V_s}{kT}\right))$$

$$\log(\frac{4Q}{\pi w^2}) = \log(n_v) + \frac{V_s}{kT}$$

#### Field effect on InN nanodomains



Surface distribution of charges (n=1.6)

#### Scattering of electrons on nanodomains



#### Electron concentration-screening action



#### Scattering length



#### conclusions

- 2-D (10 nm) InN nanotextures fabricated by PLD at 157 nm.
- Semiconductive (degenerate) response (Schottky)
- Charge memory effect (hysterisis).
- Accumulation of charges on the boundaries of nanotextures due to braking of translational symmetry and scattering of electron wavefunctions on screening

potential of the boundary.